

Search Notes

Application/Control No.

10/707,824

Examiner

W. David Coleman

Applicant(s)/Patent under
Reexamination

LIN, LONG-HUI

Art Unit

2823

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST 2.0.1 Applicants deposit a metal layer over top a dielectric then performs CMP continued	5/11/2005	WDC
-continued than scan for defects, killer and non-killer defects, text only search	5/11/2005	WDC